

FIG. 2

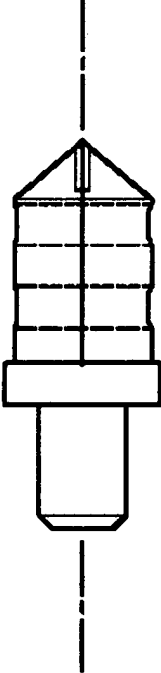


FIG. 1

Tool and fixture for measuring mechanical and electromechanical properties for IC assemblies and features - COLLIER, TERENCE

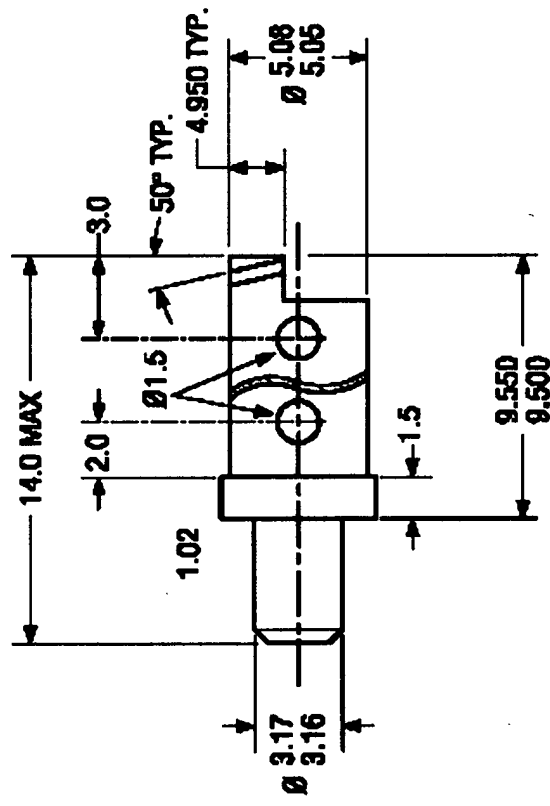


FIG. 4

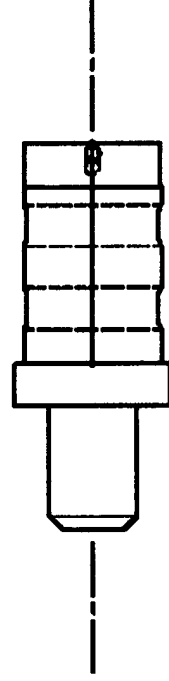


FIG. 3

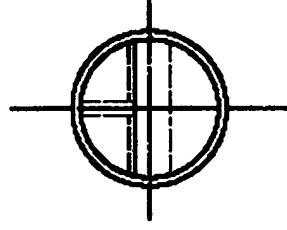


FIG. 3A